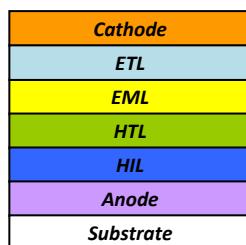
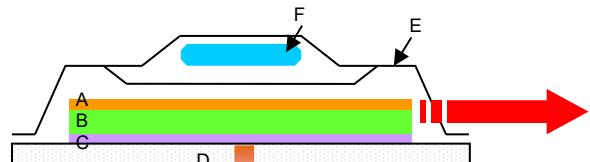


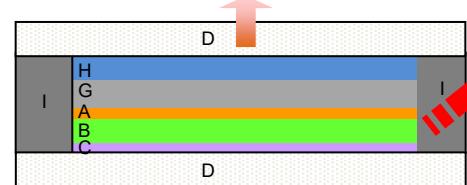
Analytical Techniques Available for OLEDs

Typical Structure of OLED

Bottom emission structure



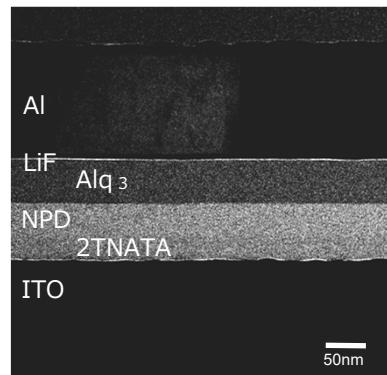
Top emission structure



- A : Cathode
- B : OLED stack
- C : Anode
- D : Substrate
- E : Package
- F : Desiccant
- G : Thin film encapsulation
- H : Optical films, etc.
- I : Edge sealant

Examples of analysis

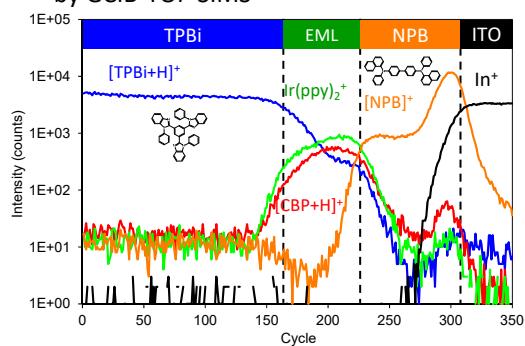
High-contrast TEM



Analytical techniques

Objective	Analytical purposes	Analytical techniques
Cathode, Anode	Compositional analysis	RBS, XPS
	Distribution of inorganics	SIMS, TEM-EDX
	Crystallinity	XRD, ASTAR
	Surface morphology	AFM, SEM
OLED stack	Cross-sectional imaging including thickness of each layer	High-contrast TEM
	Luminescence property	PL, EL, GSP+PL (PL on inclined surface)
	Chemical structure of host and dopant	GCIB-TOF-SIMS, LC/MS, MS/MS, NMR and GC/MS after LC separation
	Chemical structure of organic impurities and degradation products	GCIB-TOF-SIMS, LC-UV, LC-FL, LC/MS, MS/MS, LESA, LDI-MS
	Microanalysis of organics	TOF-SIMS
	Microanalysis of inorganics	TEM-EDX
	Distribution of inorganic impurities (interlayer diffusion, interface)	SIMS
	Film density	XRR
	Thickness, optical properties	Spectroscopic ellipsometry
	Molecular orientation	Spectroscopic ellipsometry, polarized Raman, polarized FT-IR, angle-resolved XAFS
OLED material	Crystallinity	In-Plane XRD, Raman
	Surface morphology	AFM, SEM
	Work function of single layer	XPS
TFT	Work function of multi layer	GSP+KPFM (KPFM on inclined surface)
	Inorganic impurities	ICP-MS
	Thermal properties	TG, DSC
Encapsulation (Resin, TFE)	Outgas	GC/MS, TPD-MS
	Crystallinity, grain analysis	EBSD, ASTAR
	Inorganic impurities	SIMS, TEM-EDX
	Distribution of dopants	SCM, SSRM
	Defect, film properties	CL, Raman, TEM, ESR
Encapsulation (Resin, TFE)	Compositional analysis	TOF-SIMS, micro-FT-IR, TEM-EDX, SEM-EDX
	Sealing property	SIMS with isotope marker
	Outgas from resin	GC/MS, TPD-MS

Depth profile of organic components by GCIB-TOF-SIMS



2D-NMR analysis of an organic impurity in OLED material

